

Continuous Assessment Test II - July 2023

Programme	B.Tech (CSE)	Semester	Fall Inter 2023-24
Course	Design and Analysis of Algorithms	Code	BCSE 204L
Faculty	Dr M Janaki Meena, Dr. Joe Dhanith P R, Dr. Pandiyaraju V, Dr. Senthil Kumar A M, Dr. Suguna M, Dr. Dominic Savio M	Slot/Class No.	D2 + TD2 / CH2022232500782, CH2022232500783, CH2022232500784, CH2022232500785, CH2022232500786, CH2022232500781
Time	90 Minutes	Max. Marks	50

Instructions:

- Answer all the FIVE questions.
- If any assumptions are required, assume the same and mention those assumptions in the answer script.
- Use of intelligence is highly appreciated.
- Your answer for all the questions should have both the 'design' component and the 'analysis component'
- The 'Design' component should consist: understanding of the problem, logic to develop the pseudocode, illustration, pseudocode.
- The 'Analysis' component should consist: Computation of $T(n)$, Time-complexity.

1. Let m and n be any two even positive integers. A common sequence Z_K of two strings X_m and Y_n is said to be a common end-point-sequence if either ($z_1 = x_1$ or y_1) or ($z_k = x_m$ or y_n). A common end-point sequence Z_K is said to be a common middle-end-point-sequence of X_m and Y_n if $z_{\lfloor \frac{k}{2} \rfloor} = x_{\lfloor \frac{m}{2} \rfloor}$ or $y_{\lfloor \frac{n}{2} \rfloor}$. Here, the notations Z_k , X_m , Y_n , z_i , x_i , y_i , for any k, m, n, i have the usual meaning. Given two sequences X_m and Y_n , design a dynamic programming pseudocode to compute the longest common middle-end-point-sequence of X_m and Y_n .

[Rubrics: Logic : 3 marks, Illustration: 3 marks, Pseudocode: 3 marks, Time-complexity 1 mark]

2. You are given an $n \times n$ grid with n^2 cells, in which the cells in the top row, rightmost column, bottom row and the leftmost column are filled with the digits from $\{0, 1, 2, \dots, 9\}$. That is, all the boundary cells have a digit in them. A sample grid of size 4×4 is given here for clarity.

1	7	3	4
9	4	2	0
8	1	6	5
6	2	1	3

Given an $n \times n$ grid with the digits filled in the $4n - 4$ cells, and ten digits $\{0, 1, 2, 3, \dots, 9\}$, design a pseudocode that uses backtracking strategy, to fill the remaining empty cells with the given 10 digits in such a way that

- No digit get repeated in any row
- No digit get repeated in any column

[Rubrics: Logic : 4 marks, Illustration: 2 marks, Pseudocode: 3 marks, Time-complexity 1 mark]

3. The set of all real numbers that lie between the positive integer a and the positive integer b (a and b inclusive) is denoted by $[a, b]$, read as the 'closed interval a, b '. Here, we call a and b as the end-points of the interval $[a, b]$ and size of the closed interval is $b - a$. $[2, 7]$ is a closed interval of size 5. Two closed intervals $[a_1, b_1]$ and $[a_2, b_2]$ is said to be nested-compatible if $a_1 \leq a_2$ and $b_1 \geq b_2$. A set S is said to be a nested compatible set of closed intervals if all the pairs of elements of S are nested-compatible. For example, for $S = \{[1, 10], [2, 8], [3, 5], [12, 17], [13, 15], [20, 21]\}$, the nested compatible subsets of S are $\{[1, 10], [2, 8], [3, 5]\}$ and $\{[12, 17], [13, 15]\}$. In fact, $\{[1, 10], [2, 8], [3, 5]\}$ is the maximum-size nested-compatible subset of S . Given n closed intervals $S = \{[a_1, b_1], [a_2, b_2], \dots, [a_n, b_n]\}$, design a greedy pseudocode to compute the Maximum-size nested-compatible subset of S . Your pseudocode should compute both the maximum-size of the nested-compatible subset as well the corresponding subset.

[Rubrics: Logic : 3 marks, Illustration: 3 marks, Pseudocode: 3 marks, Time-complexity 1 mark]

Let m and n be any two positive integers. A pattern $P[1, \dots, m]$ is said to be a 3-phase-pattern if P occurs in $T[1, \dots, n]$ in three phases, with different shift values. For example, $P = \text{ABEFGHI}$ is a 3-phase-pattern in $T = \text{XYZABTTEFBAAGHI}$ with $s_1 = 3, s_2 = 7, s_3 = 12$. Given a pattern $P[1, \dots, m]$, $T[1, \dots, n]$, design a pseudocode to decide whether the given pattern is 3-phase-pattern or not. If P is a 3-phase-pattern, your pseudocode should retrain all the three shift values. [10 marks]

[Rubrics: Logic : 3 marks, Illustration: 3 marks, Pseudocode: 3 marks, Time-complexity 1 mark]

5. Consider the following algorithm

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Algorithm 1: $F_1(S_1, S_2)$

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0: Input :  $S_1, S_2$ 
1:  $S_1, S_2$  are strings of same length and " indicates empty string/
2:  $n = S_1.length()$ 
3:  $d\_table[1, \dots, n] = "$ 
4:  $d\_table[1] = S_1$ 
5:  $d\_table[2] = S_2$ 
6: return  $F_2(n, d\_table)$ 
7:
8: Algorithm :  $F_2(n, d\_table)$ 
9: if  $d\_table[n] \neq "$  then
10:   return  $d\_table[n]$ 
11: end if
12:  $Sx = F_3(F_2(n-2, d\_table), F_2(n-1, d\_table))$ 
13:  $d\_table[n] = Sx$ 
14: return  $Sx$ 
15:
16: Algorithm :  $F_3(S_1, S_2)$ 
17:  $Sx = "$ 
18:  $m = S_1.length()$ 
19: for  $i = 1$  to  $m$  do
20:   if  $i \% 2 \neq 0$  then
21:      $Sx = Sx + S_1[i]$ 
22:   else
23:      $Sx = Sx + S_2[i]$ 
24:   end if
25: end for
26: return  $Sx$ 

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Understand the above algorithm and answer the following.

- For the input $ABCD, DEFG$, Compute the output of the algorithm. [2 marks]
- Describe clearly the functionality of the algorithm. [2 marks]
- Compute the time-complexity of the algorithm. [2 marks]
- Describe the design-strategy used in the algorithm. [2 marks]
- The above algorithm is modified by deleting the line:13. Compute the time-complexity of the modified algorithm. [2 marks]

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